

Search Notes**Application/Control No.**

10/777,733

Examiner

Chun-Kuan (Mike) Lee

Applicant(s)/Patent under Reexamination

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Art Unit

2181

SEARCHED

Class	Subclass	Date	Examiner
710	8	1/5/2007	CHUN-KUAN Lee
710	11	1/5/2007	
710	14-15	1/5/2007	
710	17	1/5/2007	
710	62-63	1/5/2007	
710	74	1/5/2007	
710	300-301	1/5/2007	✓

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
(EAST) US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	1/5/2007	CHUN-KUAN Lee

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner